

<b>Notice of References Cited</b>	Application/Control No. 10/607,629		Applicant(s)/Patent Under Reexamination RYOU ET AL.	
	Examiner Tuan N. Nguyen		Art Unit 2828	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,719,891	02-1998	Jewell, Jack L.	372/46.013
*	B	US-6,233,267	05-2001	Nurmikko et al.	372/46.014
*	C	US-5,985,683	11-1999	Jewell, Jack L.	438/22
*	D	US-5,724,374	03-1998	Jewell, Jack L.	372/45.01
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.